

100-441 U.S. P
09/783604

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1/2/50

Class	Subdividing

ISSUE CLASSIFICATION

PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.

PATENT DATE

SCANNED

A.G. 3.6A

APPLICATION NO. 09/783604	CONT/PRIOR F	CLASS 382	SUBCLASS 149	ART UNIT 2623	EXAMINER Joseph D. Crambo
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APPLICANTS

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TITLE

Method for analyzing circuit pattern defects and a system thereof

P5P

PTO-2040
12/89

ISSUING CLASSIFICATION

ISSUING CLASSIFICATION									
ORIGINAL			CROSS REFERENCE(S)						
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
INTERNATIONAL CLASSIFICATION									

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<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS Sheets Drwg Figs. Drwg Print Fig			CLAIMS ALLOWED	
				Total Claims	Print Claim for O.G.
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	_____ (Assistant Examiner) (Date)			NOTICE OF ALLOWANCE MAILED	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S. Patent No. _____ _____ _____				ISSUE FEE	
				Amount Due	Date Paid
<input type="checkbox"/> The terminal _____ months of this patent have been disclaimed.	_____ (Primary Examiner) (Date)			ISSUE BATCH NUMBER	
	_____ (Legal Instruments Examiner) (Date)				

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